INF 5490 RF MEMS

L14: RF MEMS inductors

S2008, Oddvar Søråsen Department of informatics, UoO

Today's lecture

- What is an inductor?
- MEMS -implemented inductors
- Modeling
- Different types of RF MEMS inductors
 - Horizontal plane inductors
 - Real solenoids
- How to increase performance
 - Q-value, Inductance (L), Self resonance frequency (f_max)
- Elevated inductors
- Inductor banks

What is an inductor?

- Inductor = a component with interaction between magnetic and electric flux
 - Magnetic field ←→ current
- Two basic laws
 - Faradays law
 - Varying magnetic field induces current
 - Amperes law
 - Current flowing sets up a magnetic field

Faradays law

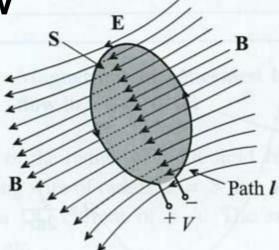


Figure 2-15 The time rate of change of the magnetic flux density induces a voltage.

$$\oint \vec{E} \cdot d\vec{l} = -\frac{d}{dt} \iint \vec{B} \cdot d\vec{S}$$

$$\vec{B} = \text{magnetisk fluks-fetthet} \quad \text{magnetic flux density}$$

$$\vec{B} = \mu \cdot \vec{H}$$

$$\mu = \text{permeability} \quad -\mu_0 \cdot \mu_1 \quad \text{permeability}$$

$$\vec{H} = \text{magnet felt} \quad \text{magnetic field}$$

Amperes law

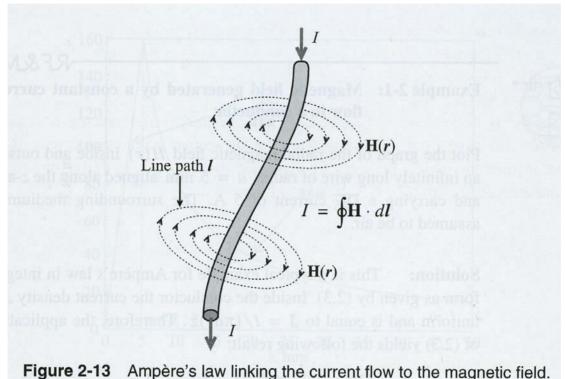


Figure 2-13 Ampère's law linking the current flow to the magnetic field.

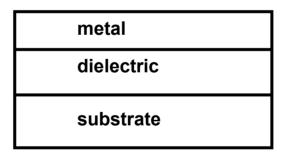
$$I = \oint \vec{H} \cdot d\vec{l} = \iint \vec{J} \cdot d\vec{s}$$

Inductors follow Faradays/Amperes laws

- Change of current in inductor →
- Change of magnetic field (Amperes law) →
- Electric field induced (Faradays law) →
- The induced electric field opposes further change in current (Lenz law)
 - Inertia with respect to changing: "reactance"
 - Mechanical analogy: mass!

Inductance

- Implemented as solenoid
 - 2D (in plane) or 3D
 - Several turns used to increase magnetic flux density
 - May give large inductance, L, for a small area
- Basic equations
 - -V = L dI/dt
 - V = Ls * I (Laplace)



Solenoids in plane are typical for IC and MEMS

Competition from IC

- Standard CMOS, SiGe-technology has given good results!
 - F.ex. Q = 12-18 @ 2 GHz, 16-22 @ 6 GHz (2003)
- Reasons for the increased IC-component performance
 - Optimizing inductor geometry using good CAD tools
 - Use of thick metal layers of gold (3 μm)
 - Use of high resistivity substrates, 10-2000 ohm-cm, reducing "eddy currents" substrate loss below the inductor (= magnetic induced currents)
 - Thick dielectric (3-6 µm oxide over substrate)

Which possibilities have RF MEMS inductors?

- Micromachined inductors should have better performance than present CMOS inductors
 - MEMS give higher Q-values!
 - Q>30
 - MEMS may give higher L and <u>self resonance-frequency</u>
- Should be CMOS compatible
 - F.ex. post CMOS processing
- Micromachined inductances not yet a commercial product

L → L, C, R -circuit

Applications of (RF MEMS) inductors

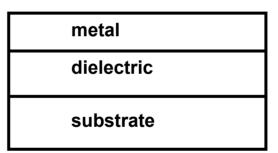
- Replacement components in
 - Low noise oscillators
 - Integrated LC-filters
 - Amplifiers
 - On-chip "matching" networks
 - Impedance transformers
 - Phase shifters

RF MEMS inductors

- Two-dimensional (planar) inductors
- Three-dimensional inductors, solenoids
- Only fixed-value inductor can be implemented
 - No practical implementation of tunable inductors exist
- Variable inductance values: implemented as inductor bank
 - Many inductors with fixed, high Q-value
 - In combination with MEMS contact switches

Planar inductors, in general

- Implemented in a single plane
- One metal layer patterned by etching
- Inductor rest on a substrate covered by a dielectric
- Loss in inductor due to:
 - Finite metal conductivity
 - Loss in dielectric
 - Loss in substrate
- Area limitations for RF
 - Total length of an inductor has to be significantly shorter than the wavelength
 - Gives then negligible phase shift of signal



Different planar geometries

- Simple line sections
 - Each one has a low inductance value, nH
- Meander
 - Coupling by negative mutual inductances
- Spiral inductors
 - Higher L, higher Q
 - Problem: connecting to the inner winding
 - Wire bonding
 - Separate structure layer
 - Flip-chip methods

Contribution to inductance

- Self inductance from own winding
- Mutual inductance from neighbouring windings
 - Mutual coupling between neighbour lines
- Total inductance is the sum of self inductance and mutual inductance
 - In some elements current flows in the same direction, in others opposite

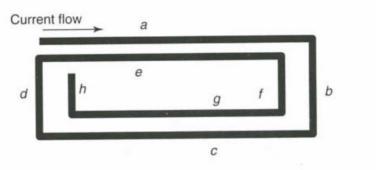


Figure 4.2 Spiral inductor and the effect of current flow in nearby segments

Different planar geometries

- Distance between lines is critical
- Circular spiral has a shorter length than a quadratic spiral
 - $\rightarrow Lower R$
 - Q is about 10% higher with same "diameter", do
- Higher Q achieved by increasing number of turns per area
 - Self resonance frequency decreases due to the increase in capacitance → limits the region of use

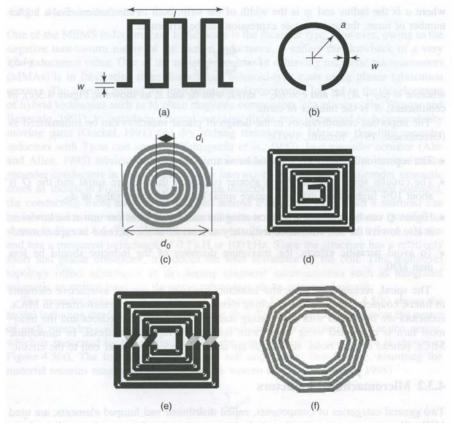


Figure 4.3 Schematic diagram of common planar inductors: (a) meander; (b) loop; (c) circular spiral; (d) square spiral; (e) symmetric spiral; (f) polygon spiral

Inductor is a non-ideal component

- Changes its value versus frequency
 - Becomes capacitive

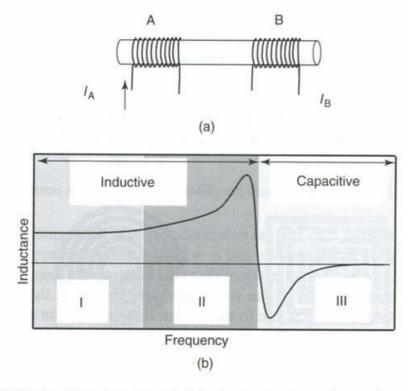


Figure 4.1 (a) Self-inductance and mutual inductance due to a change in current; (b) typical operational regions of an inductor. Note: I_A and I_B , current in coils A and B, respectively

General model for a planar inductor

Ls is low frequency inductance

Rs is series resistance

Cs is capacitance between windings

C1 is capacitance in oxide layer between inductor and substrate

Cp is capacitance to ground through substrate

Rp is "eddy current" loss in substrate

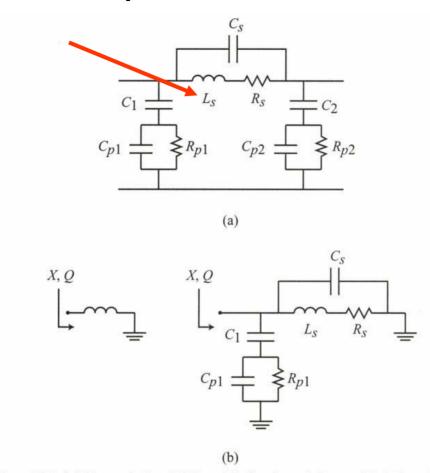


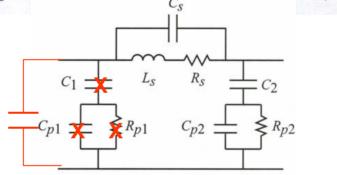
Figure 12.1. (a) The equivalent LRC model of a planar inductor. (b) A short-circuited inductor model typically used in S-parameter and Q measurements. C_{p1} and C_{p2} are often assumed identical and equal to C_p .

Frequency response for a planar inductor

At low frequencies we have

$$Z = R_s + j\omega L_s \tag{12.1}$$

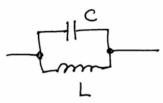
- At high frequencies:
 - Rp1 is negligible
 - C1 and Cp1 combined
 → Cp



$$Z = (R_s + j\omega L_s) \left\| \left(\frac{1}{\omega C_s} \right) \right\| \left\{ \frac{1}{\omega C_1} + \left(\frac{1}{\omega C_{p1}} \| R_{p1} \right) \right\}$$
(12.2)

Parallel resonator

Panallell risonans



$$\frac{1}{jwc} + jwL = 0$$

$$Z = \infty$$

$$Q_{ind} = \omega L/R$$

At resonance:

Due to parasitic capacitances a specific self resonance frequency is obtained

$$\frac{1}{2} \cdot \left(\frac{1}{2} \right) \cdot \left($$

$$Z = \frac{j_{\omega}c}{j_{\omega}c} \cdot (R + j_{\omega}L) = -j_{\omega}L \cdot (R + j_{\omega}L)$$

$$= -j_{\omega}L \cdot (R + j_{\omega}L) = -j_{\omega}L \cdot (R + j_{\omega}L)$$

$$= -j_{\omega}L$$

$$Z = \frac{\omega^2 L^2}{R} - j\omega L \approx \frac{\omega^2 L^2}{R}$$

Ex.: Inductor reactance

Resistance is here defined at 2 GHz

R is supposed to vary as sqrt (f) over 2 GHz due to the skin effect

Parallel-type resonance at 8 GHz, phase also changes

At resonance the input impedance of a parallel resonator is real and given by:

$$Z_{res} = \frac{\left(\omega L_s\right)^2}{R_s} \tag{12.3}$$

Figure shows that simple L, R – model is valid to 0.5 f_resonance

Phase properties show that the component is inductive also for higher frequencies

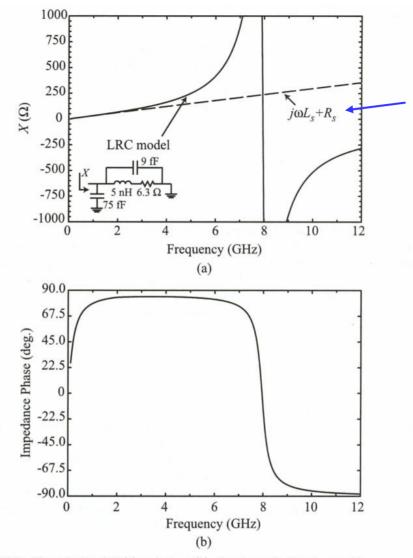


Figure 12.2. The calculated X (a) and phase (b) of a planar 5-nH inductor. The resonant frequency is 8 GHz and the resistance is assumed constant up to 2 GHz and then increases as \sqrt{f} .

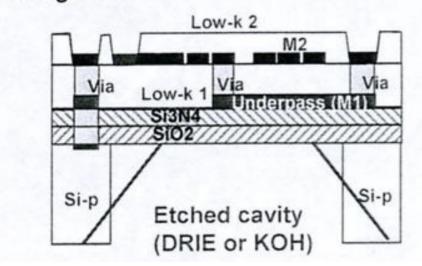
Today's lecture

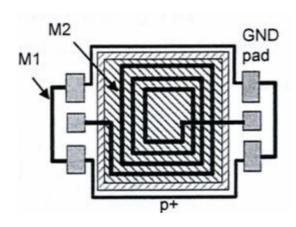
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Example: Thick copper/polyimide horizontal-plane inductor

Process (EPF Lausanne, WIDE-RF):

 \bullet 4-8 μm electroplated Cu in polyimide mold using Ta barriers





"Form" ("mold") of organic material

Ex. CMOS – MEMS inductor

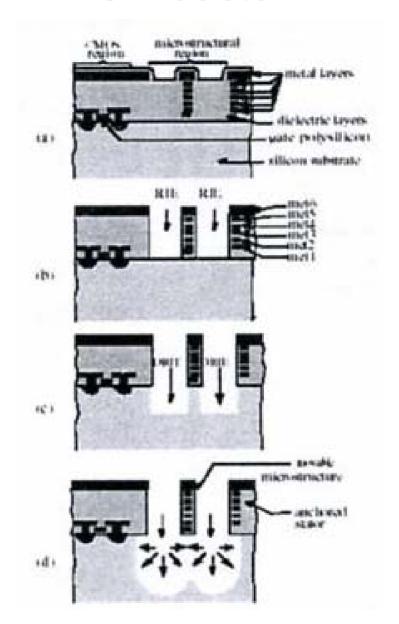
- High Q, 6 Cu layers
- Low-ε dielectric
- Post-CMOS processing
 - Standard CMOS + RIE post processing + isotropic etch
- X. Zhu et al

Carnegie Mellon University

Ex. from Transducers 2001

Anisotropic etching followed by isotropic etching

Top metal layer is mask



Ex. Spiral inductor (Ahn & Allen)

- Two solenoids
- Magnetic core used for trapping magnetic flux
 - Must be a high permeability material
 - Ex. Varadan fig. 4.7(Ahn & Allen) →



centre needed!

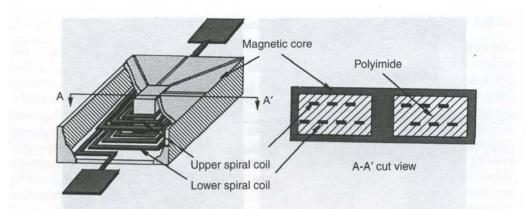


Figure 4.7 Schematic diagram of a micromachined spiral inductor. Reproduced from C.H. Ahn and M.G. Allen, 1993, 'A planar micromachined spiral inductor for integrated magnetic microactuator applications', *Journal of Micromechanics Microengineering* **3**: 37–44, by permission of the Institute of Physics

Effect of magnetic core

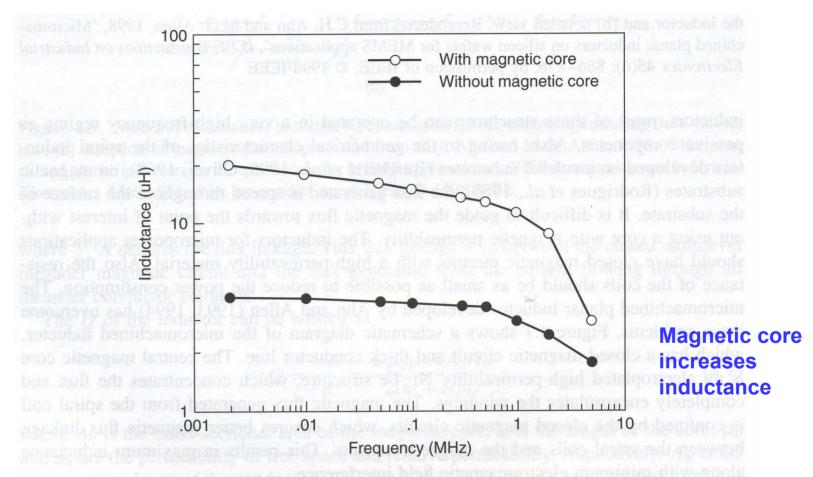


Figure 4.8 Measured inductance with and without magnetic core. Reproduced from C.H. Ahn and M.G. Allen, 1993, 'A planar micromachined spiral inductor for integrated magnetic microactuator applications', *Journal of Micromechanics Microengineering* **3**: 37–44, by permission of the Institute of Physics

Meander inductors

- Meander has lower inductance than spiral inductor
- Meander fabricated by surface processing
 - a) Metal conductor in one layer
 - Penetrated by multilevel magnetic core
 - b) Schematic of principle →
 - Ala magnetic core in one layer surrounded by metal turns

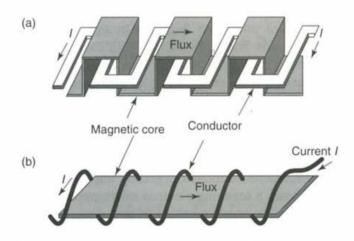


Figure 4.4 Schematic diagram of the micromachined multilevel meander inductor. Reproduced from C.H. Ahn and M.G. Allen, 1998, 'A fully integrated surface micromachined microactuator with a multilevel meander magnetic core', *Journal of Microelectromechanical Systems* **2**(1): 15−22, by permission of IEEE, © 1998 IEEE

Meander fabricated (SEM picture)

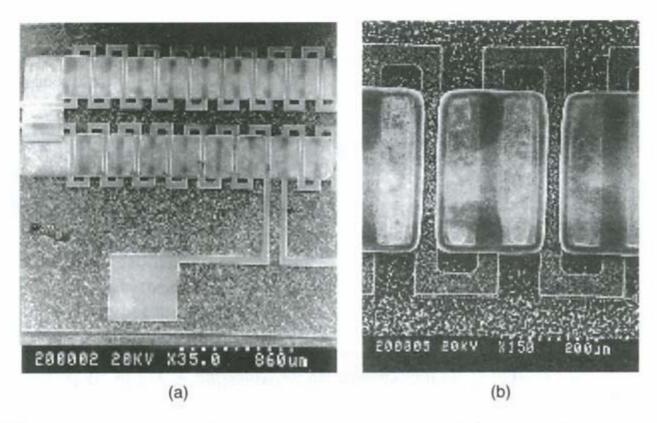


Figure 4.6 Scanning electron micrograph of the fabricated toroidal-meander inductor: (a) half of the inductor and (b) detailed view. Reproduced from C.H. Ahn and M.G. Allen, 1998, 'Micromachined planar inductors on silicon wafers for MEMS applications', *IEEE Transactions on Industrial Electronics* **45**(6): 866−876, by permission of IEEE, © 1998 IEEE

Meander: effect of different line widths

- Influence of the line width (C vs width)
 - "sheet resistance"
 is inverse
 proportional to w
 → decreases!
 - Resistance
 decreases if w
 increases, but the
 capacitance
 increases

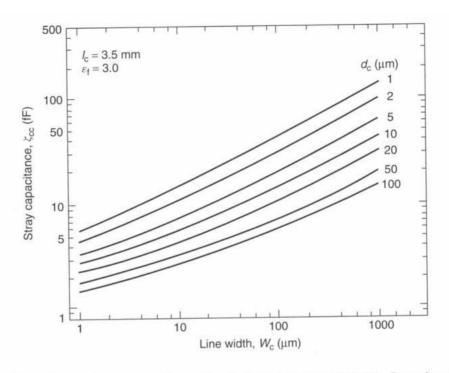


Figure 4.11 Computed stray capacitance due to change in line width W_c . Reproduced from M. Yamaguchi, M. Mastumo, H. Ohzeki and K.I. Arai, 1991, 'Analysis of the inductance and the stray capacitance of the dry-etched micro inductors', *IEEE Transactions on Magnetics* **27**(6): 5274–5276, by permission of IEEE, © 1991 IEEE

dc = distance between conductors

Effect of stripe width w on Q-factor

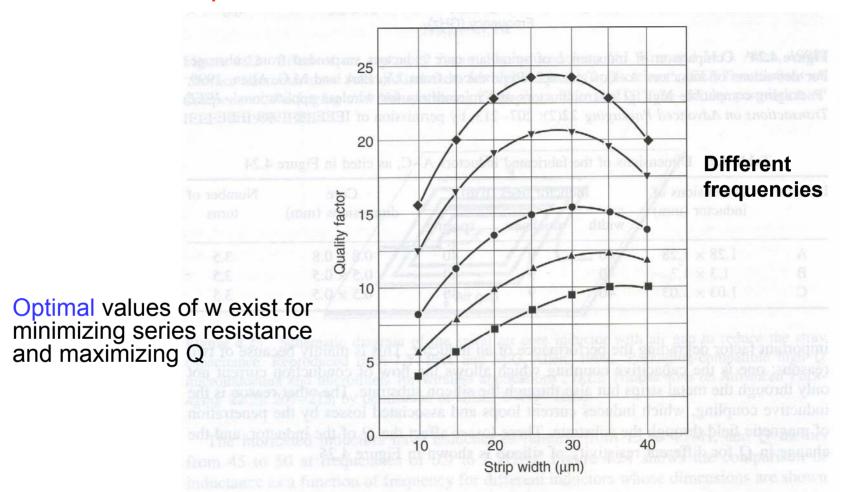
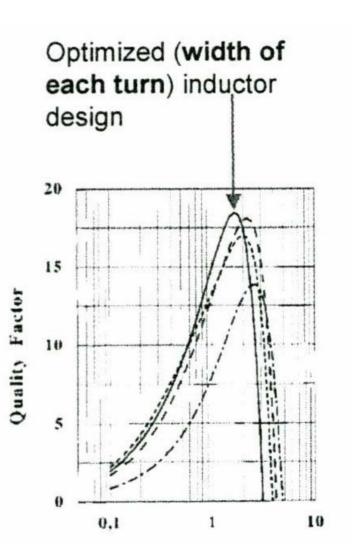


Figure 4.26 Change in Q due to change in strip width for 20-nH inductors for different frequencies: ■, 7 GHz; ♠, 1 GHz; ♠, 1.5 GHz; ▼, 2.5 GHz; and ♠, 3.5 GHz. Reproduced from I.J. Bahl, 1999, 'Improved quality factor spiral inductors on GaAs substrates', *IEEE Microwave and Guided Wave Letters* 9(10): 398–400, by permission of IEEE, © 1999 IEEE

Optimization

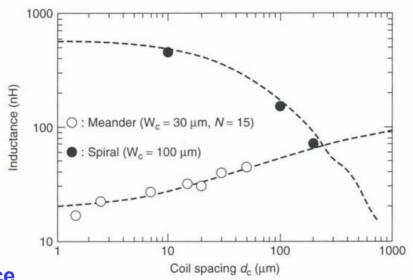
- Width of each turn can be optimized
 - Each turn has a constant resistance





Effect of different implementations

How line distance influences L



Different effect for spiral and meander: constructive versus destructive mutual inductance

Figure 4.10 Change in inductance arising from changes in spacing between the conductors for meander and spiral inductors. Reproduced from M. Yamaguchi, M. Mastumo, H. Ohzeki and K.I. Arai, 1991, 'Analysis of the inductance and the stray capacitance of the dry-etched micro inductors', *IEEE Transactions on Magnetics* **27**(6): 5274–5276, by permission of IEEE, © 1991 IEEE

- Effect of number of turns on L and Q
- Spiral inductors with same dimensions
- n: 3 \rightarrow 8:
 - L increases
 - Q decreases (due to increase in C)

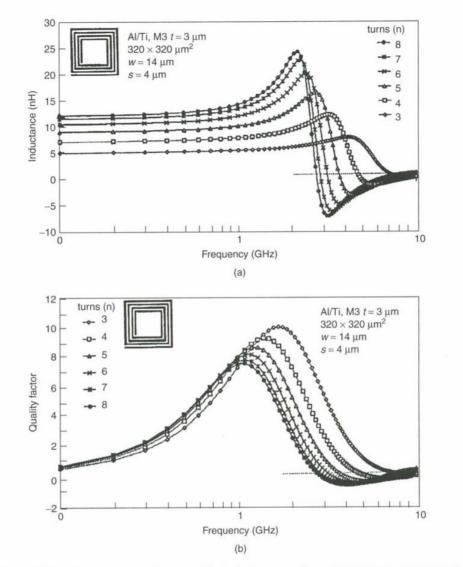
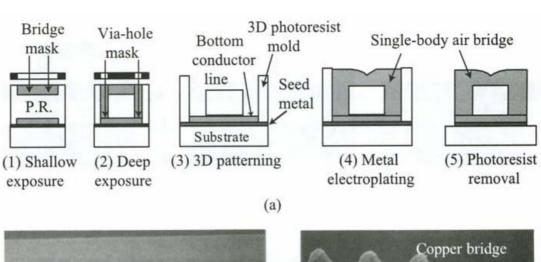


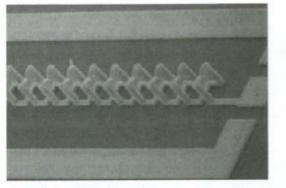
Figure 4.12 Effect of number of turns on (a) the inductance value and (b) Q factor. Reproduced from Y.K. Koutsoyannopoulos and Y. Papananos, 2000, 'Systematic analysis and modeling of integrated inductors and transformers in RF IC design', *IEEE Transactions on Circuits and Systems II* 47(8): 699–713, by permission of IEEE, © 2000 IEEE

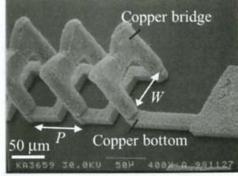
Solenoid-type inductors

- Classical example
- Process using thick photo resist form
 - $-45 60 \mu m deep$
- Top fabricated using copper: electroplating
 - seed + 20 30
 μm copper layer
 on top
- Result: "loops" formed



(b)





Solenoid-type copper inductors

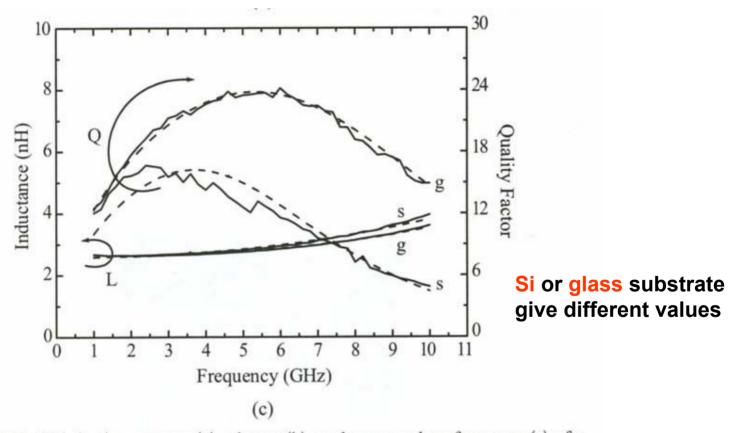


Figure 12.14. Fabrication process (a), picture (b), and measured performance (c) of a 2.4-nH all-copper solenoid inductor on silicon and glass substrates [24, 25] (Copyright IEEE).

Results from Yoon et al.

Extreme type

- Solenoid-type inductor with large alumina core
 - Placed manually on a Si-substrate, fig. →
 - Cross section 650 x 500 µm2
 - Photo resist on alumina core
 - Direct write laser,3D
 - Electroplating
 - 5-10 μm copper
 - Not practical!

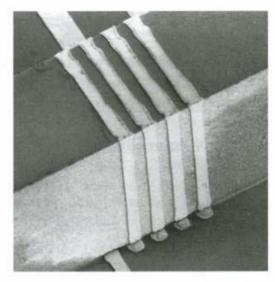


Figure 12.16. A solenoid-type four-turn inductor using a large alumina core [28] (Copyright IEEE).

Young et al., 1997

Example of 3-D structure

Difficult to produce

- Nickel-iron (permalloy) magnetic core
- Multilevel copper + viacontacts
- Contacts have high contact resistance
- Need of many turns to get high L
 - More contacts → higher resistance
 - Electroplating of metal lines and via holes may reduce resistance and increase performance

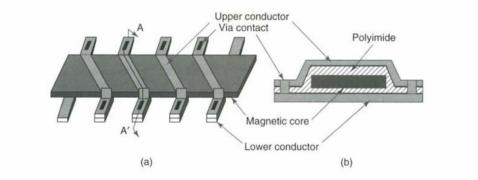


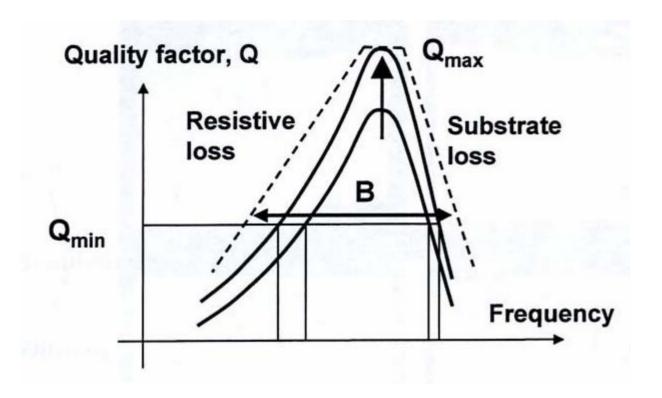
Figure 4.9 Schematic diagram of a solenoid-type inductor: (a) schematic view; (b) cross-sectional view at AA'. Reproduced from C.H. Ahn and M.G. Allen, 1998, 'Micromachined planar inductors on silicon wafers for MEMS applications', *IEEE Transactions on Industrial Electronics* **45**(6): 866–876, by permission of IEEE, © 1998 IEEE

Ahn & Allen, 1998

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Q-factor depends on resistive loss and substrate loss



For low frequencies: resistive loss limits Q For high frequencies: substrate loss limits Q

Improving Q-factor

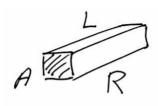
- Metallization is important
 - Reduction of resistive loss

- Use metals with higher conductivity
 - Use copper, Cu, instead of Al

Use thicker structures

Effect of metal thickness

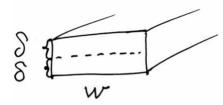
- Series resistance limits performance
- Simulations show that minimum thickness of 2 x "skin depth" is needed to obtain minimum resistance



$$S = \text{resistivity}$$

$$R = S - L$$

$$A$$



Resistance per length

$$\frac{R}{L} = \frac{\rho}{A} = \frac{\rho}{28 \cdot w}$$

skin depth =
$$\int \frac{\rho}{\pi \mu \cdot d} \sim \frac{1}{\sqrt{g}}$$

$$\frac{R}{L} \sim \frac{1}{8}$$

 μ = permeability ρ = resistivity

Thick conductors needed

- For copper at 1 Ghz: skin depth is about 2 µm
- One should have conductors of min 2 x skin depth thickness
 - E.g. about 4 5 μm for Cu
 - Thick layer!
 - Typically obtained by electroplating

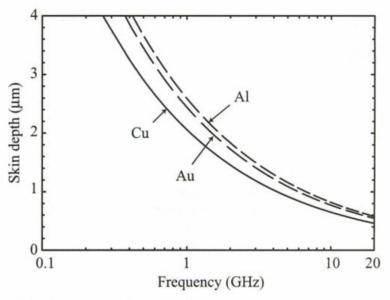


Figure 12.4. Skin depth versus frequency for copper, gold, and aluminum metal layer (bulk values of resistivities are assumed).

Change of Q versus metal thickness

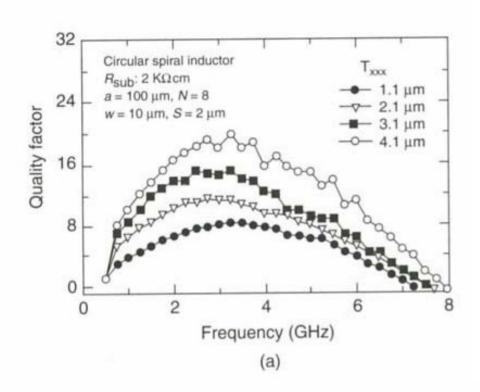


Figure 4.29 Change in *Q* of an inductor for (a) different metal thickness; (b) for substrates with different resistivity. Reproduced from M. Park, C.S. Kin, J.M. Park, H.K. Yu and K.S. Nam, 1997b, 'High *Q* microwave inductors in CMOS double metal technology and its substrate bias effects for 2 GHz RF IC application', in *Proceedings of IEDM 97*, IEEE, Washington, DC: 59−62, by permission of IEEE, © 1997 IEEE

Double level metallization

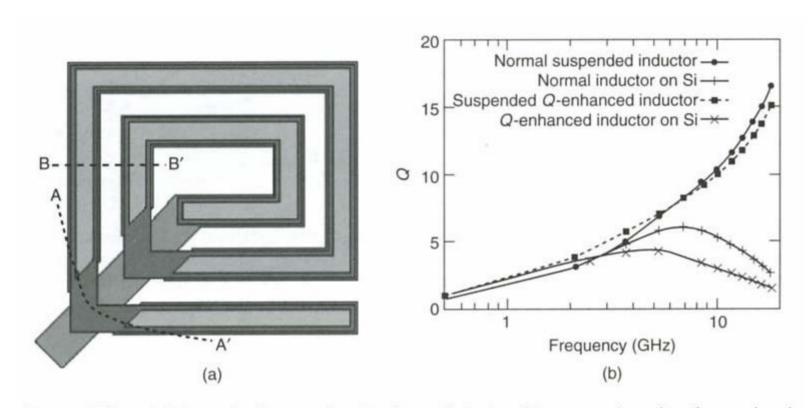


Figure 4.27 (a) Schematic diagram of a *Q*-enhance inductor; (b) measured results of normal and *Q*-enhanced inductors. Reproduced from Y. Sun, J.L. Tauritz and R.G.F. Baets, 1999, 'Micromachined RF passive components and their applications in MMICs', *International Journal of RF and Microwave CAE* 9: 310−25, © Wiley (1999), by permission of Wiley

4.5 μ m \rightarrow 9 μ m, on/without 10 μ m polyimide layer

Micromachining using thick metal layers

Thick BCB layer (Benzocyclobutene, low ε dielectric, polymer) 10 μm thick copper-layer

Post-CMOS, low-temperature processing

The thick copper layer is beneficial due to the large surface of the copper inductor relative to skin depth

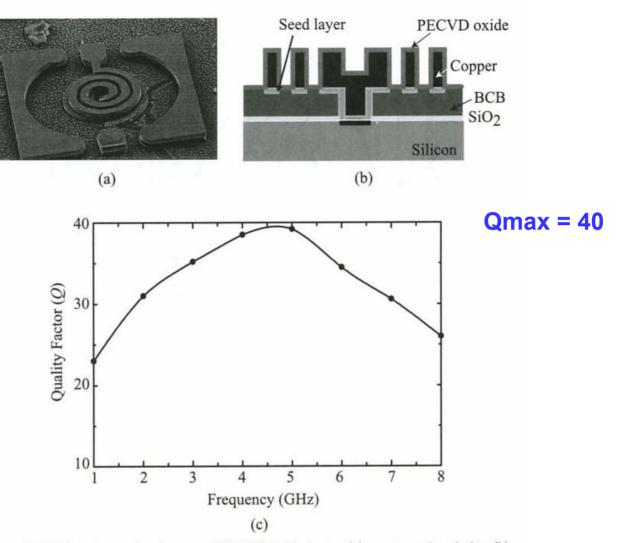


Figure 12.7. The electroplated copper MEMSCAP inductor (a), cross-sectional view (b), and the measured Q of a 1.5-nH inductor [12] (Copyright IEEE).

Substrate etching

- Parasitic capacitance between inductor and ground plane is a problem
 - Depends on type and thickness of dielectric
 - Depends on type and thickness of substrate
- Solution: etching of substrate
 - Reduction of parasitic capacitance
 - Q increases
 - Resonance frequency is shifted to higher frequency
 - Increases the useful bandwidth of the inductor
 - High L can be implemented without having too low f max

Substrate
capacitance effect
on Q and reactance
X

At 1 – 4 GHz series resitance limits

Figure shows that higher Q also gives a higher self resonance frequency

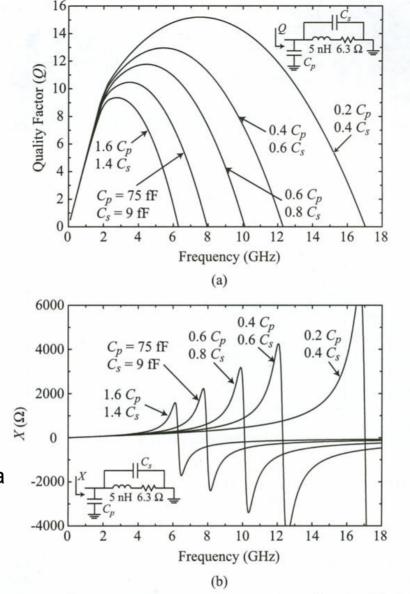


Figure 12.6. The effect of the substrate capacitance on the Q (a) and X (b) of a 5-nH inductor. The resistance is assumed constant up to 2 GHz and then increases as \sqrt{f} .

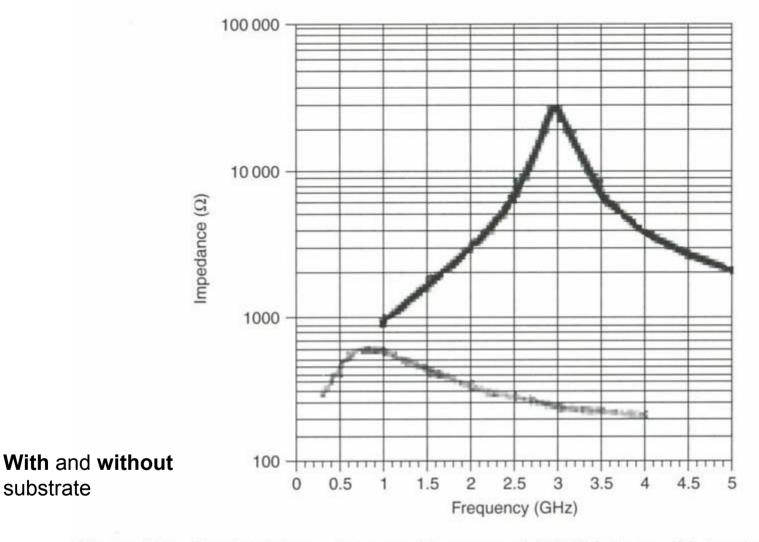
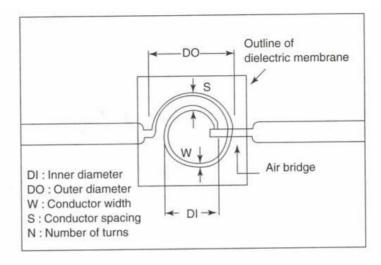


Figure 4.13 Simulated change in resonant frequency of 100 nH inductor with (gray) and without (black) underlying substrate. Reproduced from J.Y.-C. Chang, A.A. Abidi and M. Gaitan, 1993, 'Large suspended inductors on silicon and their use in a 2 mm CMOS RF amplifier', IEEE Electron Device Letters 14(5): 246-248, by permission of IEEE, © 1993 IEEE

substrate

Test system

 Example system for testing the effect of having a solenoid on a membrane or on Si



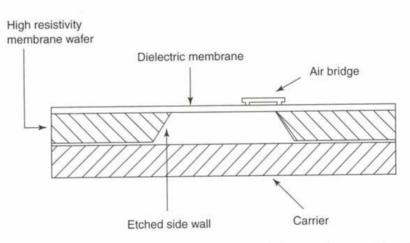


Figure 4.14 Schematic diagrams of the planar inductor and the membrane outline. Reproduced from C.-Y. Chi and G.M. Rebeiz, 1995, 'Planar microwave and millimeter wave lumped elements and coupled line filters using micromachining technique', *IEEE Transactions on Microwave Theory and Techniques* 43(4): 730–738, by permission of IEEE, © 1995 IEEE

Achieved L on Si and membrane

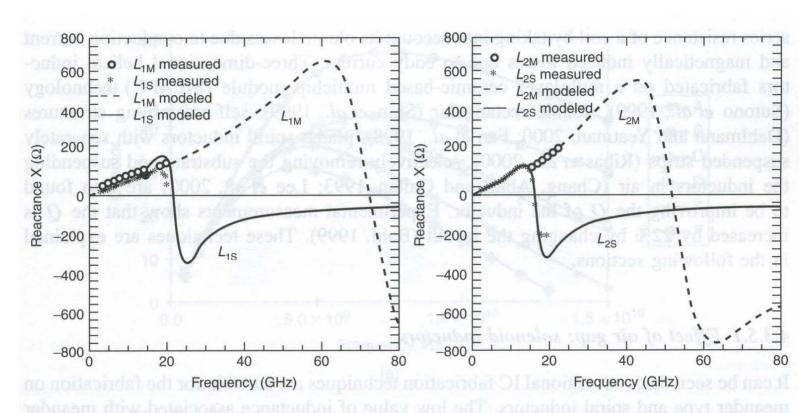


Figure 4.15 Measured and modeled reactance for inductors on silicon (L_{1S}, L_{2S}) and on membrane (L_{1M}, L_{2M}) . Reproduced from R. Rodrigues, J.M. Dishman, F.D. Dickens and E.W. Whelan, 1980, 'Modeling of two-dimensional spiral inductors', *IEEE Transactions Components*, *Hybrids*, *Manufacturing Technology* **5**: 535–541, by permission of IEEE, © 1980 IEEE

M = membrane, S = Si

Ex.: Q for different etch depths

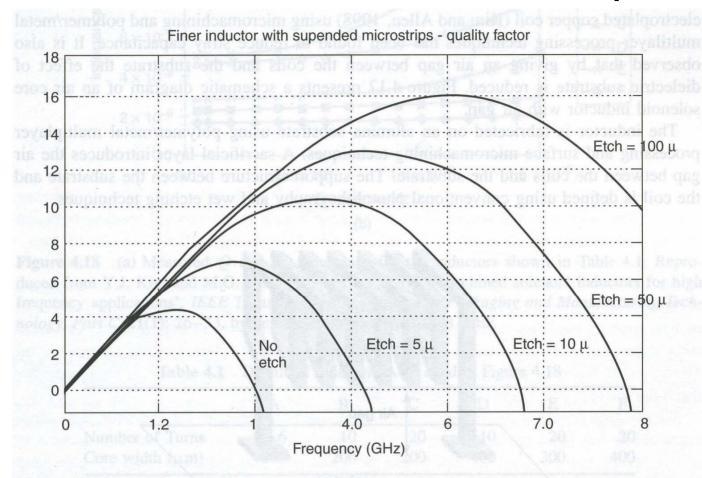


Figure 4.16 The change in Q for a suspended planar inductor for different etch depth. Reproduced from R.P. Ribas, N. Bennouri, J.M. Karam and B. Courtois, 1997, 'GaAs MEMS design using $0.2\,\mu\mathrm{m}$ HEMT MMIC technology', in *Proceedings of the 19th Annual IEEE Gallium Arsenide Integrated Circuit Symposium*, IEEE, Piscataway, NJ, USA: 127–130, by permission of IEEE, © 1997 IEEE

Different substrate materials

- Substrate etching has no effect on Q for low frequencies
 - Rs is the limitation
 - Rs is prop with sqrt(f)

- Look at the effect of different substrate materials
 - Different resistivity

Q-factor for substrates with different resistivities

"Eddy current"-effects present at high frequency

High resistivity substrate increases performance

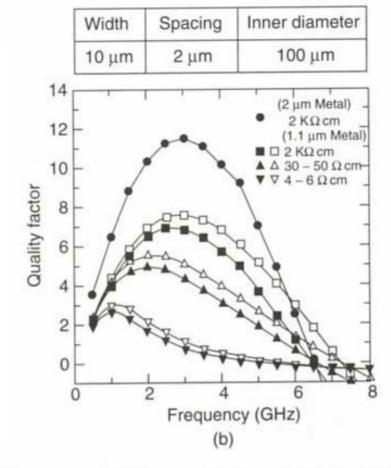
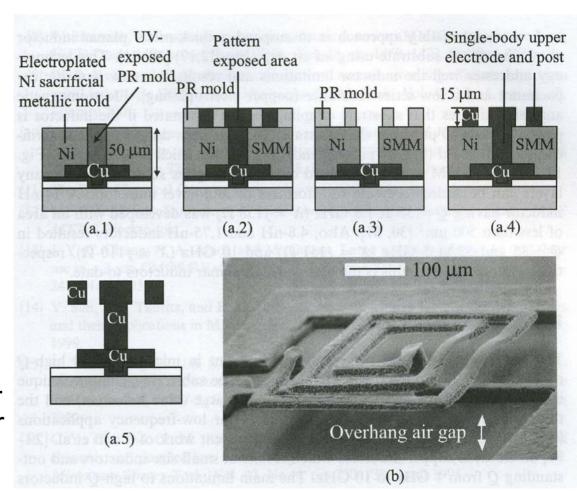


Figure 4.29 Change in *Q* of an inductor for (a) different metal thickness; (b) for substrates with different resistivity. Reproduced from M. Park, C.S. Kin, J.M. Park, H.K. Yu and K.S. Nam, 1997b, 'High *Q* microwave inductors in CMOS double metal technology and its substrate bias effects for 2 GHz RF IC application', in *Proceedings of IEDM 97*, IEEE, Washington, DC: 59−62, by permission of IEEE, © 1997 IEEE

"Air gap" - inductor

- Thick metal planar inductor over substrate with an air gap in-between
 - Elimination of substrate coupling:30 µm elevation
 - "Sacrificial metallic mold" (SMM)
 process used + 10 15 µm copper layer



Performance to inductor above air gap

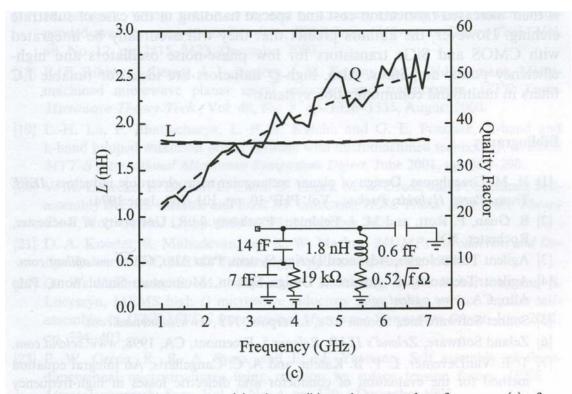


Figure 12.17. Fabrication process (a), picture (b), and measured performance (c) of an overhang inductor using 15-μm-thick copper layers [29, 30] (Copyright IEEE).

- Ex. from the first known work, fig 12.8 a: anisotropic etching
- Fig 12.8 b: suspended inductor
 - One anchor, sensitive to mechanical vibrations
 - Q = 17 at 8.6GHz

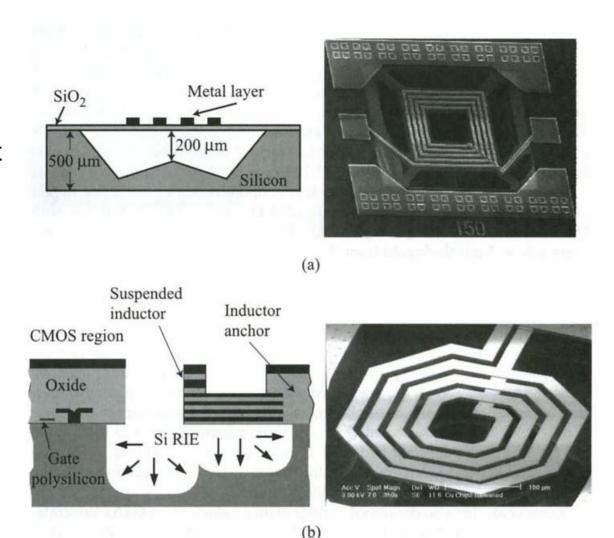


Figure 12.8. Suspended inductors using front-etching techniques and compatible with CMOS processing: UCLA and Delft [13, 14] (a), Carnegie Mellon (b), effort [15] (Copyright IEEE).

Air-gap for solenoids

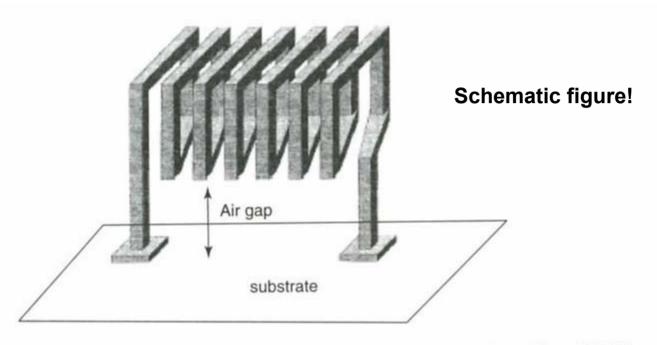


Figure 4.17 Schematic diagram of a solenoid inductor with an air gap. Reproduced from Y.J. Kim and M.G. Allen, 1998, 'Surface micromachined solenoid inductors for high frequency applications', *IEEE Transactions on Components, Packaging and Manufacturing Technology, Part C* **21**(1): 26–33, by permission of IEEE, © 1998 IEEE

Effect of air-gap for spiral inductors

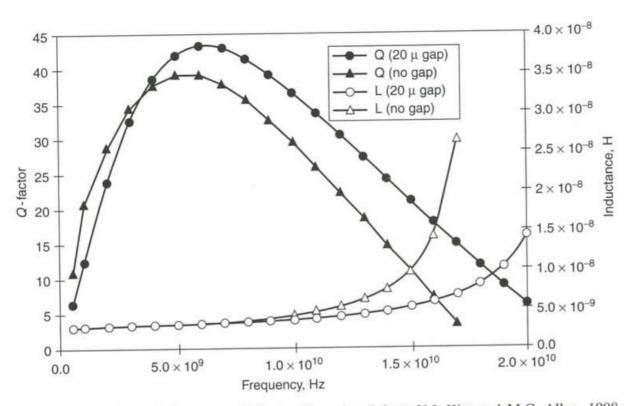


Figure 4.22 Effect of air gap on Q factor. Reproduced from Y.J. Kim and M.G. Allen, 1998, 'Surface micromachined solenoid inductors for high frequency applications', *IEEE Transactions on Components, Packaging and Manufacturing Technology, Part C* 21(1): 26–33, by permission of IEEE, © 1998 IEEE

L benefits from "no-gap", Q benefits from air-gap

Summary: How to increase performance?

- Have thick metal layer with good conductivity
 - To reduce series resistance
- Use substrate etching
 - Reduce substrate parasitic capacitance
- Use 3-D structures
 - For vertical plane solenoids the L-value may increase
- Use of core material

Basic implementation technologies

- Thick metal electroplateing
 - 0.2 6 GHz
- Substrate etching
 - 1 100 GHz
- Three-dimensional solenoid type inductors
 - High L and Q-values
 - 0.2 6 GHz
- "Self-assembly" (elevation) of inductor ->
 - Elevate inductor above substrate to reduce parasitic capacitance to substrate, 1 – 100 GHz

Folded and elevated inductors

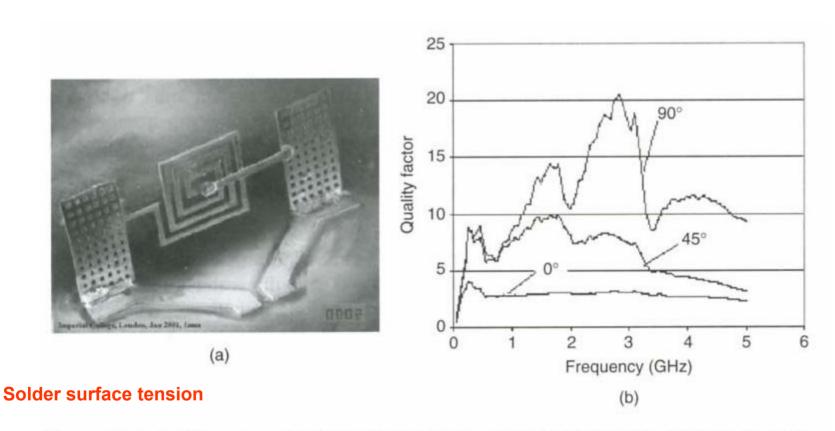
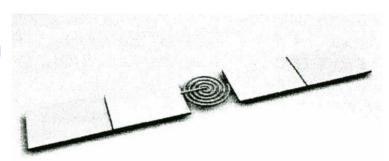


Figure 4.30 (a) Three-turn spiral folded inductor after self-assembly; and (b) change in Q against frequency for different angles between coil and substrate. All devices are $4\frac{1}{2}$ -turn meander inductors ($L=2\,\mathrm{nH}$). Reproduced from G.W. Dahlmann and E.M. Yeatman, 2000, 'High Q microwave inductors on silicon by surface tension self-assembly', *Electronics Letters* 36(20): 1707–1708, by permission of IEEE, © IEEE 2000 Eric. Yeatman, Imperial College, London

Out of plane inductors

- Inductor can be elevated by "scratch actuators"
 - L. Fan et al, MEMS 1998
 - Elevated 250 µm over Si substrate
 - Resonance at 1.8 6.6 GHz after elevation of solenoid



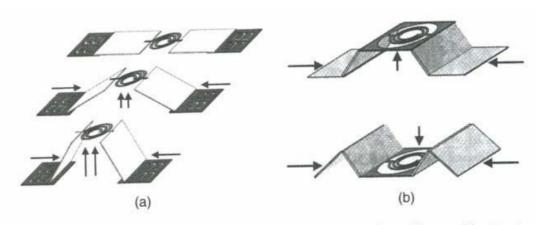


Figure 4.31 (a) Schematic diagram of the MESA micro-elevator by self-assembly structure; (b) the center platform can move upward or downward. Reproduced from L. Fan, R.T. Chen, A. Nepolsa and M.C. Wu, 1998, 'Universal MEMS platforms for passive RF components: suspended inductors and variable capacitors', in *Proceedings of 11th Annual International Workshop on MEMS* '98, IEEE, Washington, DC: 29−33, by permission of IEEE, © 1998 IEEE

Micromachining using self-assembly

Elevate inductor above substrate to reduce parasitic capacitance

Cr-Au layer over polylayer

Different residual **stress** in materials make the inductor "**curl**" above substrate

Anchor causes a significant parasitic capacitance

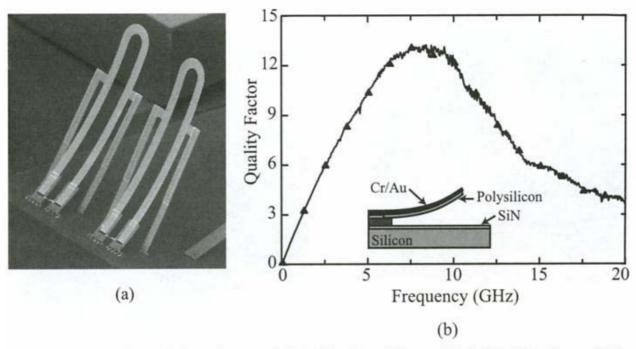


Figure 12.12. Picture (a) and measured Q (b) of a self-assembled 1.2-nH inductor [20] (Copyright IEEE).

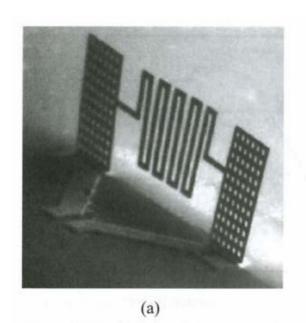
Solder surface tension used

Photo resist as sacrificial layer

Copper structure
with solder pads
between anchor and
a free movable
structure

Heating to 185 ° C → solder pads melt and pull, due to surface tension force, the structure to a vertical position

Cooling → solder hardens



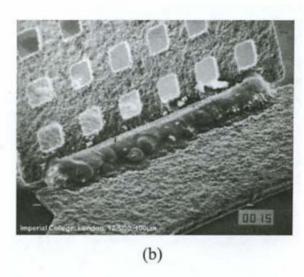
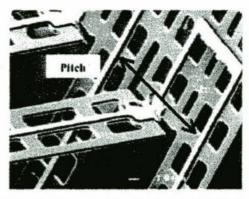
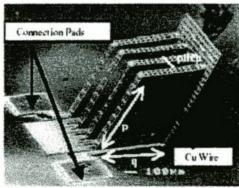


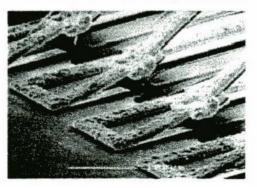
Figure 12.13. (a) Out-of-plane meander-type inductors after self-assembly, and (b) a blow-up of the solder hinges after heating [22, 23] (Copyright IEEE).

Structure with suspension hinges

- Copper structure can manually be folded and glued
- Typical "turns" with large dimensions ~100 µm
- M. Gel et al, Transducers 2001



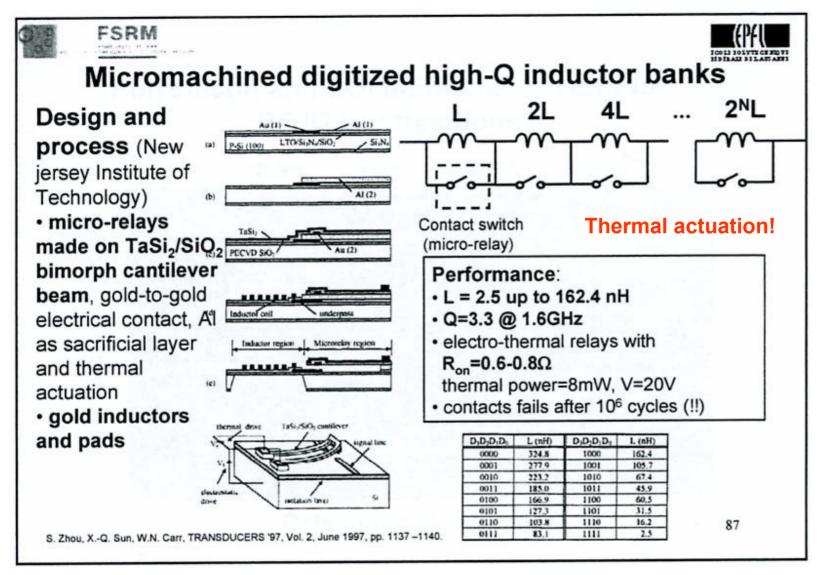




Today's lecture

- What is an inductor?
- MEMS -implemented inductors
- Modeling
- Different types of RF MEMS inductors
 - Horizontal plane inductors
 - Real solenoids
- How to increase performance
 - Q-value, Inductance (L), Self resonance frequency (f_max)
- Elevated inductors
- Inductor banks

Programmable inductor banks



How different design parameters influence performance

Q_max and f_rez decrease when area and number of turns increase

Integrated inductor performance versus design space

After Varadan et al. [3]

		Q_{max}	L	f _{rez}
Conductor thickness	7	7	-	-
Sheet resistance	7	Z	-	_
Insulator thickness	7	71	-	7
Substrate resistivity	7	NZ	-	71
Area	7	Z	7	7
Number of turns	7	Z	7	Z
Track width	7	71	Z	7
Multilayer inductor (extra layer)	7	Я	71	Я

(Double arrow: less influence)